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# MOSFET - Power, Dual N- & P-Channel, SO8FL

100 V, 13.4 mΩ, 60 A, -100 V, 36 mΩ, -36 A

## NTMFC013NP10M5L

#### Features

- Small Footprint (5 x 6 mm) for Compact Design
- Low RDS(on) to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Typical Applications**

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- Motor Drive, Home Automation

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C, Unless otherwise specified)

Pa	Parameter				Q2	Unit
Drain-to-Source	e Breakdow	n Voltage	V <sub>(BR)DSS</sub>	100	-100	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	±20	V
Continuous Drain Current R <sub>θJC</sub> (Note 2)	Steady State	T <sub>C</sub> = 25°C	Ι <sub>D</sub>	60	-36	A
Power Dissi- pation R <sub>θJC</sub> (Note 2)			P <sub>D</sub>	102	102	W
Continuous Drain Current R <sub>θJA</sub> (Notes 1, 2)	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	9	-5	A
Power Dissi- pation R <sub>0JA</sub> (Notes 1, 2)			P <sub>D</sub>	2.7	2.7	W
Pulsed Drain Current	T <sub>A</sub> = 25°0	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	208	-184	A
Operating Juncti perature Range	on and Sto	rage Tem-	T <sub>J</sub> , T <sub>stg</sub>	–55 to	o +150	°C
Source Current (Body Diode)			۱ <sub>S</sub>	85	85	А
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L</sub> = 17.9/18.4 A, L = 1 mH)			E <sub>AS</sub>	161	169	mJ
Soldering Purpos	Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)			260	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 in<sup>2</sup> pad size, 1 oz Cu pad.

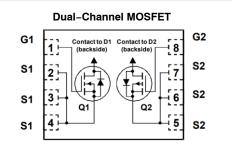
The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.



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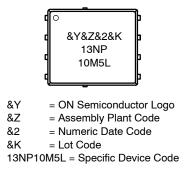
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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
100 V	13.4 m $\Omega$ @ 10 V	60 A
–100 V	36 mΩ @ 10 V	–36 A





MARKING DIAGRAM



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 10 of this data sheet.

#### THERMAL CHARACTERISTICS

Symbol	Parameter	Q1	Q2	Unit
$R_{ extsf{ heta}JC}$	Junction-to-Case - Steady State (Note 3)	1.46	1.46	°C/W
$R_{ hetaJA}$			55	

3. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

#### **ELECTRICAL CHARACTERISTICS (Q1, N-CHANNEL)** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_D = 25$	50 μΑ	100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>	$I_D = 250 \ \mu\text{A}$ , ref to $25^{\circ}\text{C}$			60		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		$T_J = 25^{\circ}C$			1	μA
		$V_{GS}$ = 0 V, $V_{DS}$ = 80 V	T <sub>J</sub> = 125°C			100	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = :	±20 V			±100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 15	58 μΑ	1.0	1.7	3.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> / T <sub>J</sub>	$I_D = 158 \ \mu A$ , ref to	25°C		8.85		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8.5 A			9.16	13.4	mΩ
		$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 6.8 \text{ A}$			15.2	35.0	1
Forward Transconductance	g <sub>FS</sub>	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 8.5 \text{ A}$			15.5		S
Gate-Resistance	R <sub>G</sub>	$T_A = 25^{\circ}C$			1.57		Ω
CHARGES & CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 50 V			1345		pF
Output Capacitance	C <sub>OSS</sub>				307		1
Reverse Transfer Capacitance	C <sub>RSS</sub>				17.5		
Total Gate Charge	Q <sub>G(TOT)</sub>				12		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				2.4		1
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 50 V	/, I <sub>D</sub> = 8.5 A		4.7		1
Gate-to-Drain Charge	Q <sub>GD</sub>				5		1
Total Gate Charge	Q <sub>G(TOT)</sub>				23		1
Plateau Voltage	V <sub>GP</sub>	V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 50 V	, I <sub>D</sub> = 8.5 A		3.3		V
SWITCHING CHARACTERISTICS					•		•
Turn-On Delay Time	t <sub>d(ON)</sub>				12		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V. V <sub>DS</sub> = 50 V	, I <sub>D</sub> = 8.5 Α.		8		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 50 V, $I_{D}$ = 8.5 A, $R_{G}$ = 6 $\Omega$			30		1
Fall Time	t <sub>f</sub>				10		
Turn-On Delay Time	t <sub>d(ON)</sub>				20.1		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 50 V	. I <sub>D</sub> = 8.5 А		40.9		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$R_{\rm G} = 6 \Omega$	,,		22.7		1
Fall Time	t <sub>f</sub>				16		1

#### ELECTRICAL CHARACTERISTICS (Q1, N-CHANNEL) (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit

OFF CHARACTERISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V$ , $T_{J} = 25^{\circ}C$		0.77	1.2	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 8.5 A	$T_{\rm J} = 125^{\circ}C$	0.63		
Reverse Recovery Time	t <sub>RR</sub>			39		ns
Charge Time	t <sub>a</sub>	V <sub>GS</sub> = 0 V, dI <sub>S</sub> /dt =	22			
Discharge Time	t <sub>b</sub>	$V_{GS}$ = 0 V, dI_S/dt = 100 A/µs, I_S = 4.2 A		17		
Reverse Recovery Charge	Q <sub>RR</sub>			38		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### ELECTRICAL CHARACTERISTICS (Q2, P-CHANNEL) (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = -2$	50 μA	-100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>	$I_D = -250 \ \mu\text{A}, \text{ ref to } 25^\circ\text{C}$			60		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			-1	μA
		$V_{\rm DS} = -80$ V	T <sub>J</sub> = 125°C			-100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> =	±20 V			±100	nA
ON CHARACTERISTICS		•					
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = -158 \ \mu A$		-2.0	-3.31	-4.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> <sup>/ T</sup> J	$I_D = -158 \ \mu\text{A}$ , ref to 25°C			6.9		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = -8.5 A			28.5	36	mΩ
		$V_{GS} = -6 \text{ V}, \text{ I}_{D} = -5.7 \text{ A}$			38.3	50.1	
Forward Transconductance	9fs	$V_{DS} = -5 \text{ V}, \text{ I}_{D} = -8.5 \text{ A}$			17.7		S
Gate-Resistance	R <sub>G</sub>	$T_A = 25^{\circ}C$			2.41		Ω
CHARGES & CAPACITANCES		•					
Input Capacitance	C <sub>ISS</sub>				2443		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = –50 V			330		
Reverse Transfer Capacitance	C <sub>RSS</sub>				15		
Total Gate Charge	Q <sub>G(TOT)</sub>				30		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				6.9		
Gate-to-Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = -10 V, V <sub>DS</sub> = -50 '	V, I <sub>D</sub> = -8.5 A		10.4		
Gate-to-Drain Charge	Q <sub>GD</sub>				5.1		
Total Gate Charge	Q <sub>G(TOT)</sub>				18.4		
Plateau Voltage	V <sub>GP</sub>	$V_{GS} = -6 \text{ V}, \text{ V}_{DS} = -50 \text{ V}, \text{ I}_{D} = -8.5 \text{ A}$			5		V
SWITCHING CHARACTERISTICS		•					
Turn–On Delay Time	t <sub>d(ON)</sub>				12.4		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = -50 V	. In = -8.5 A.		16.1		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$R_{\rm G} = 6 \Omega$	, , , , ,		20		
Fall Time	t <sub>f</sub>	1			24		

#### ELECTRICAL CHARACTERISTICS (Q2, P-CHANNEL) (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

t<sub>b</sub>

 $Q_{RR}$ 

Discharge Time

Reverse Recovery Charge

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = –6 V, $V_{DS}$ = –50 V, $I_{D}$ = –8.5 A, $R_{G}$ = 6 $\Omega$			27		ns
Rise Time	t <sub>r</sub>				25		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				22		
Fall Time	t <sub>f</sub>			8.5			
OFF CHARACTERISTICS							
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V.$	$T_J = 25^{\circ}C$		-0.84	-1.2	V
		$V_{GS} = 0 V,$ $I_{S} = -8.5 A$ $T_{J} = 125^{\circ}C$			0.7		
Reverse Recovery Time	t <sub>RR</sub>				39		ns
Charge Time	t <sub>a</sub>	Vcs = 0 V dls/dt =		23			

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

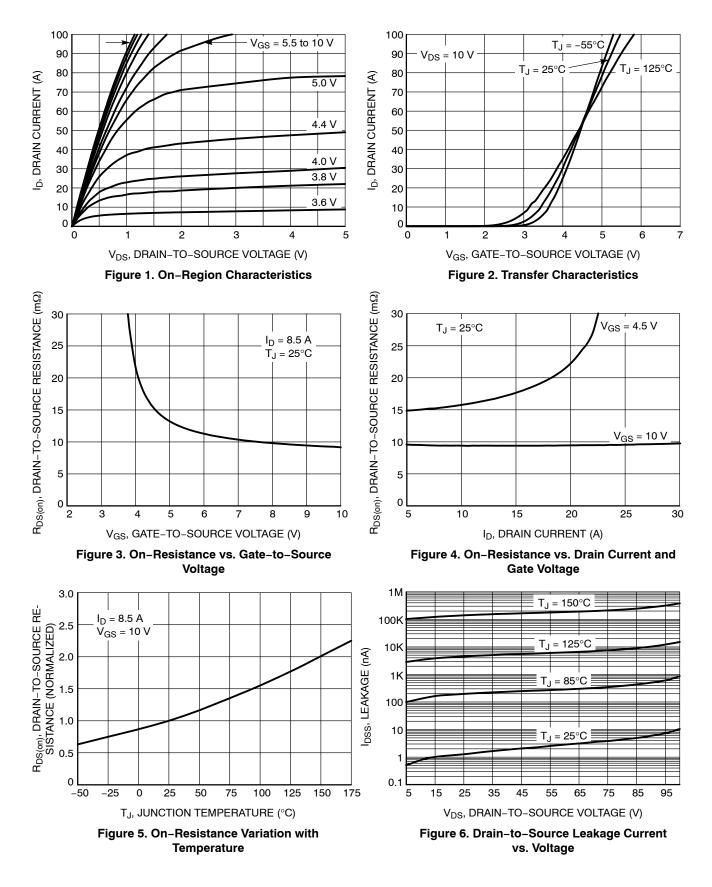
 $\label{eq:VGS} \begin{array}{l} V_{GS} = 0 \ V \! , \, dI_S \! / \! dt = 100 \ A \! / \! \mu s \! , \\ I_S = -4.2 \ A \end{array}$ 

16.6

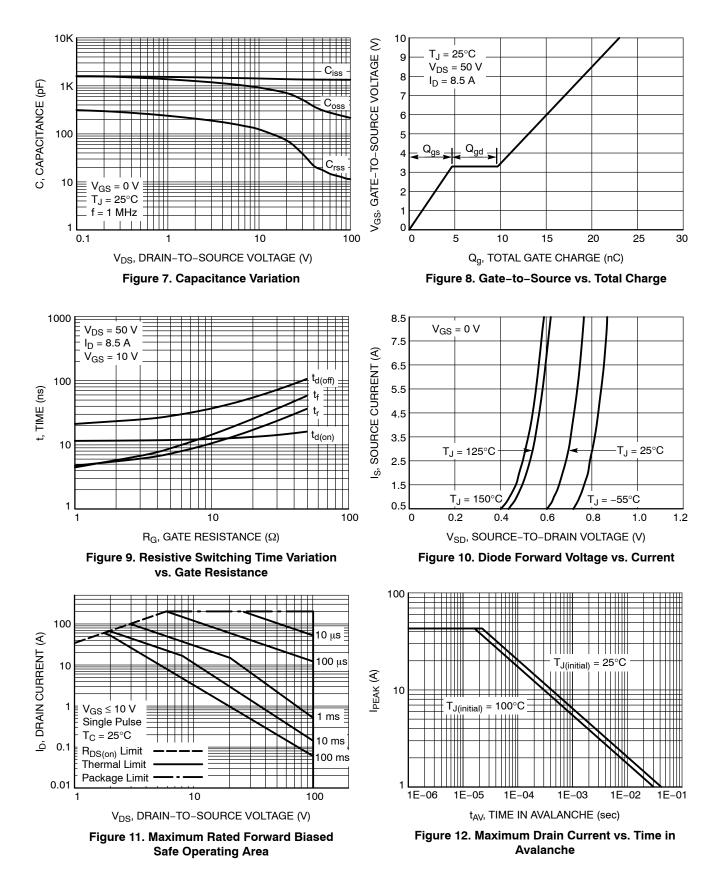
38

nC

#### **TYPICAL CHARACTERISTICS – N-CHANNEL**



#### **TYPICAL CHARACTERISTICS – N-CHANNEL**



#### **TYPICAL CHARACTERISTICS – N-CHANNEL**

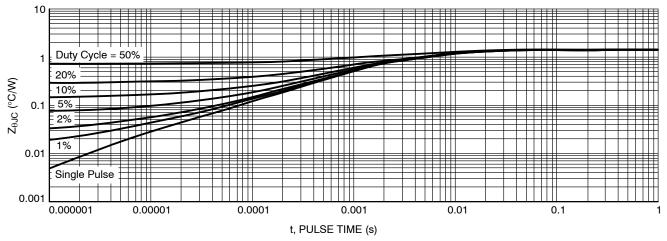
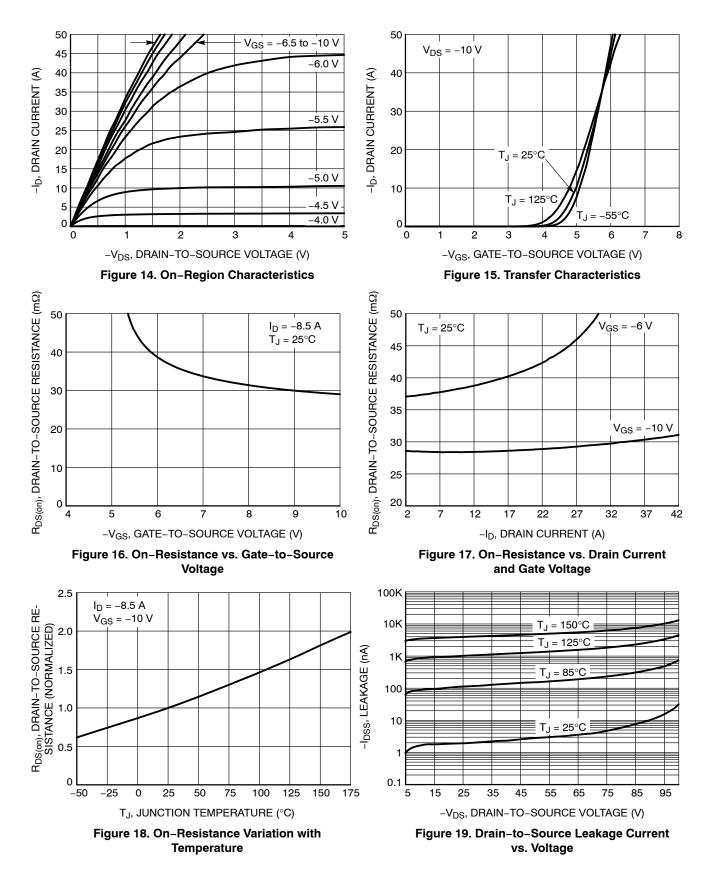
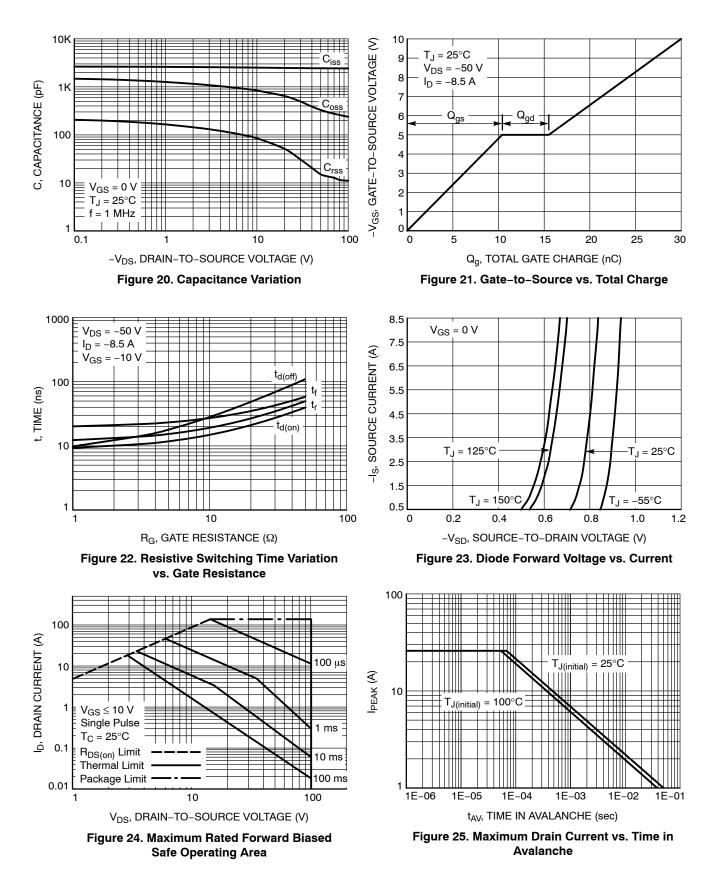


Figure 13. Thermal Response

#### **TYPICAL CHARACTERISTICS – P-CHANNEL**



#### **TYPICAL CHARACTERISTICS – P-CHANNEL**



#### **TYPICAL CHARACTERISTICS – P-CHANNEL**

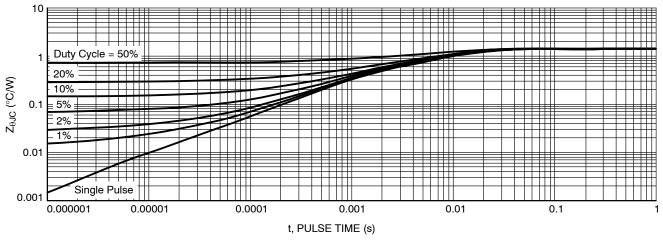


Figure 26. Thermal Response

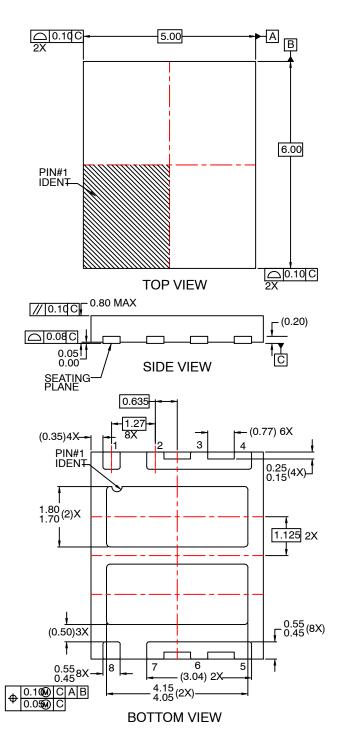
#### **ORDERING INFORMATION**

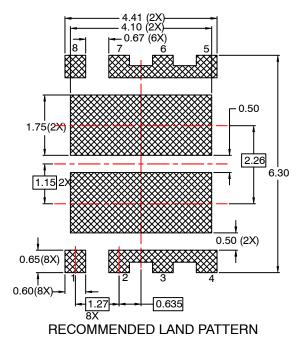
	Device	Device Marking	Package	Shipping (Qty / Packing) $^{\dagger}$
NTMF	C013NP10M5L	13NP10M5L	SO8FL (Pb–Free/Halogen Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

WDFN8 5x6, 1.27P CASE 511DC ISSUE O





NOTES:

- A. DOES NOT FULLY CONFORM TO JEDEC REGISTRATION, MO-229.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.

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